


<b>Search Notes</b>  	<b>Application/Control No.</b>  10632865	<b>Applicant(s)/Patent Under Reexamination</b>  KIM, EUNG-SUN
	<b>Examiner</b>  Tekle, Daniel	<b>Art Unit</b>  2621

SEARCHED			
Class	Subclass	Date	Examiner
386	82	04/29/07	DT

SEARCH NOTES		
Search Notes	Date	Examiner
East data base (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	04/29/07	DT
Search query attached	04/29/07	DT
Combined citation	04/29/07	DT
NPL; Inventor search	04/29/07	DT
Search updated	10/11/07	D.T.
Search query updated and attached	04/13/08	D.T.
Search updated	11/10/08	D.T.

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

--	--